

**N-Channel Enhancement Mode Power MOSFET****MTN13N50CFP**

BV_{DSS}	500V
I_D @V_{GS}=10V, T_C=25°C	13A
I_D @V_{GS}=10V, T_C=100°C	8.2A
R_{DS(ON)}@V_{GS}=10V, I_D=6.5A	0.42 Ω (typ)

Description

The MTN13N50CFP is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-220FP package is universally preferred for all commercial-industrial applications

Features

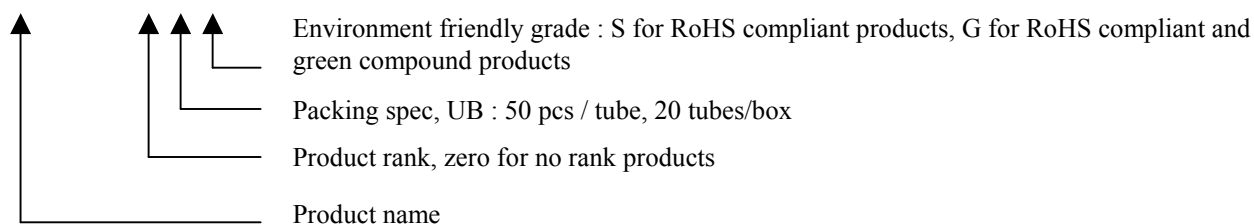
- Low On Resistance
- Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- Insulating package, front/back side insulating voltage=2500V(AC)
- RoHS compliant package

Applications

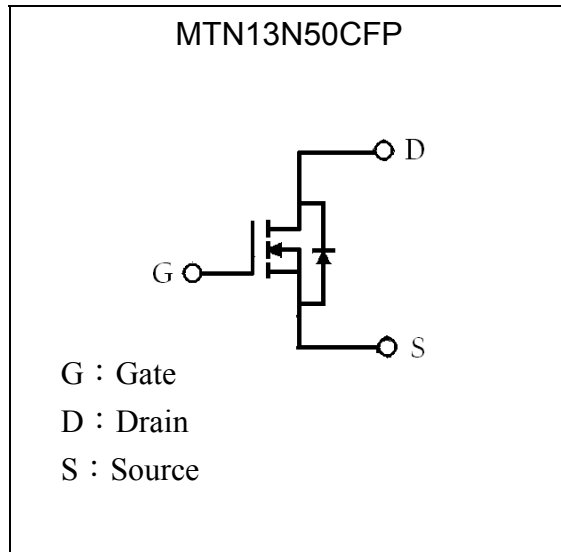
- Power Factor Correction
- LCD TV Power
- Full and Half Bridge Power

Ordering Information

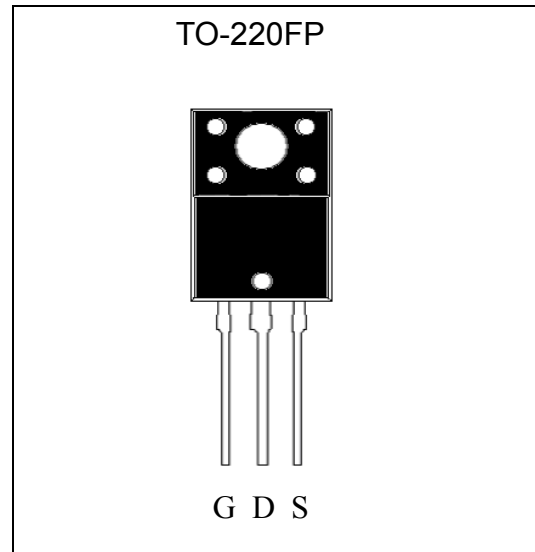
Device	Package	Shipping
MTN13N50CFP-0-UB-S	TO-220FP (RoHS compliant package)	50 pcs/tube, 20 tubes/box, 4 boxes / carton



Symbol



Outline



Absolute Maximum Ratings (T_C=25°C)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage (Note 1)	V _{DS}	500	V
Gate-Source Voltage	V _{GS}	±30	
Continuous Drain Current @ V _{GS} =10V, T _C =25°C	I _D	13*	A
Continuous Drain Current @ V _{GS} =10V, T _C =100°C		8.2*	
Pulsed Drain Current @ V _{GS} =10V (Note 2)	I _{DM}	52*	
Single Pulse Avalanche Energy @ L=8mH, I _D =4Amps, V _{DD} =50V	E _{AS}	64	mJ
Single Pulse Avalanche Current (Note 2)	I _{AS}	4	A
Maximum Temperature for Soldering @ Lead at 0.063 in(1.6mm) from case for 10 seconds	T _L	300	°C
Maximum Temperature for Soldering @ Package Body for 10 seconds	T _{PKG}	260	
Total Power Dissipation (T _C =25°C)	P _D	48	W
Linear Derating Factor above 25°C		0.4	W/°C
Operating Junction and Storage Temperature	T _j , T _{stg}	-55~+150	°C

*Drain current limited by maximum junction temperature

*100% UIS testing in condition of V_{DD}=50V, L=8mH, V_G=10V, I_L=3A, Rated V_{DS}=500V

Note : 1. T_J=+25°C to +150°C.

2. Pulse width limited by maximum junction temperature.

**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{\theta JC}$	2.58	°C/W
Thermal Resistance, Junction-to-ambient, max	$R_{\theta JA}$	62.5	

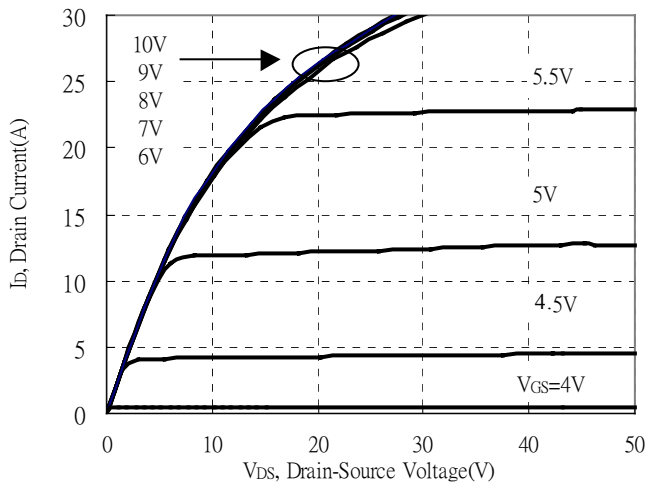
Characteristics (T_j=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	500	-	-	V	V _{GS} =0V, I _D =250μA
ΔBV _{DSS} /ΔT _j	-	0.6	-	V/°C	Reference to 25°C, I _D =250μA
V _{GS(th)}	2.0	-	4.0	V	V _{DS} = V _{GS} , I _D =250μA
*G _{FS}	-	15	-	S	V _{DS} =15V, I _D =6.5A
I _{GSS}	-	-	±100	nA	V _{GS} =±30V
I _{DSS}	-	-	1	μA	V _{DS} =500V, V _{GS} =0V
I _{DSS}	-	-	10		V _{DS} =400V, V _{GS} =0V, T _j =125°C
*R _{DS(ON)}	-	0.42	0.53	Ω	V _{GS} =10V, I _D =6.5A
Dynamic					
*Q _g	-	35.8	-	nC	I _D =13A, V _{DD} =250V, V _{GS} =10V
*Q _{gs}	-	7.6	-		
*Q _{gd}	-	10.8	-		
*t _{d(ON)}	-	17	-	ns	V _{DD} =250V, I _D =13A, V _{GS} =10V, R _G =9.1 Ω
*tr	-	16.8	-		
*t _{d(OFF)}	-	63.4	-		
*tf	-	31.8	-		
C _{iss}	-	1479	-	pF	V _{GS} =0V, V _{DS} =25V, f=1MHz
C _{oss}	-	150	-		
Cr _{ss}	-	36	-		
Source-Drain Diode					
*I _S	-	-	13	A	
*I _{SM}	-	-	52		
*V _{SD}	-	0.79	1.2	V	I _S =6.5A, V _{GS} =0V
*trr	-	318	-	ns	V _{GS} =0, I _F =13A, dI _F /dt=100A/μs
*Qrr	-	3.02	-	μC	

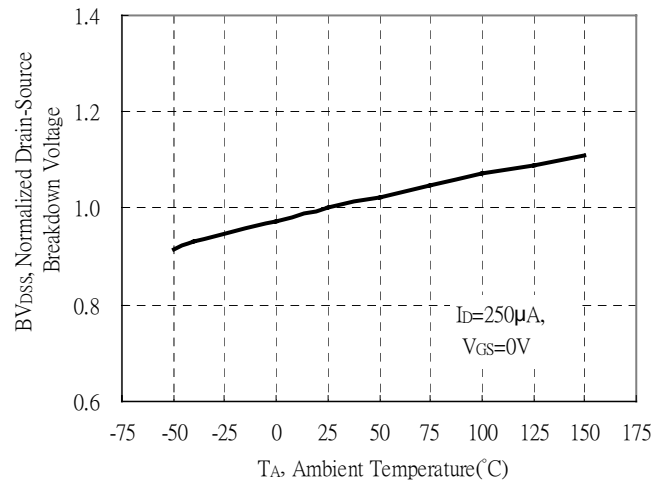
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Typical Characteristics

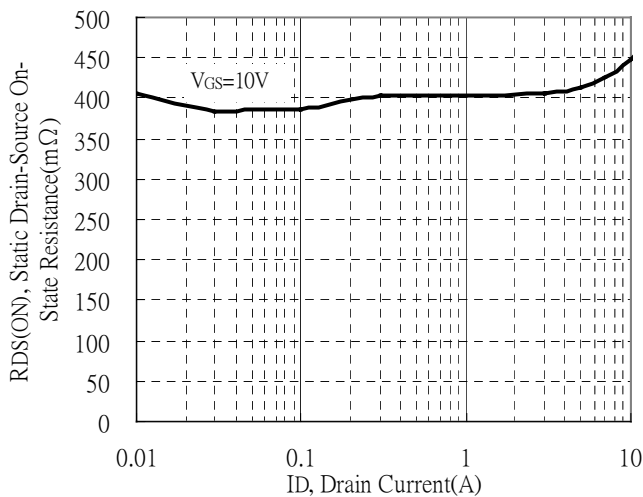
Typical Output Characteristics



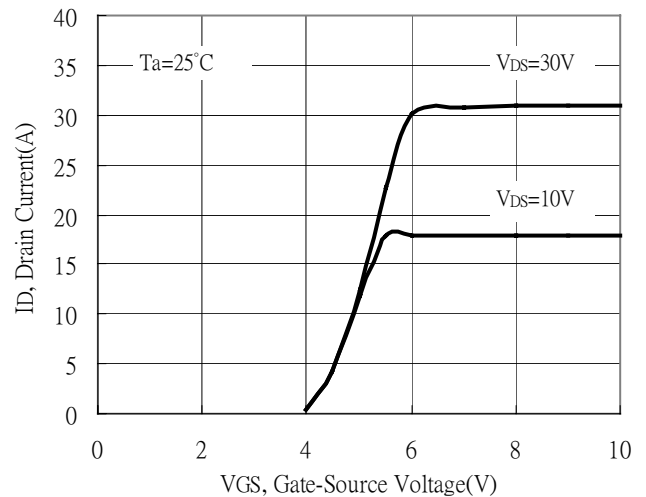
Brekdown Voltage vs Ambient Temperature



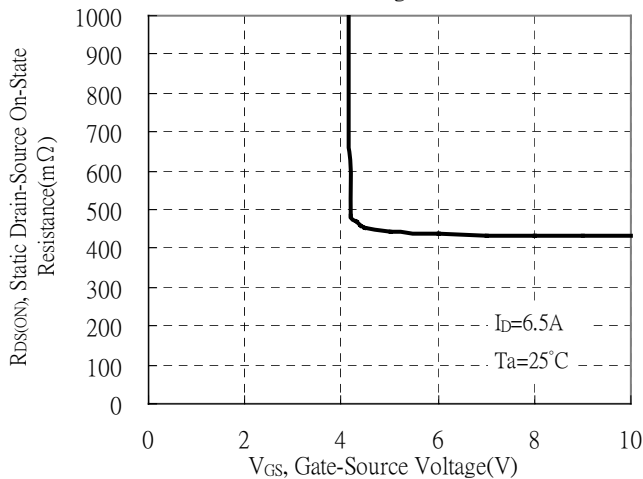
Static Drain-Source On-State resistance vs Drain Current



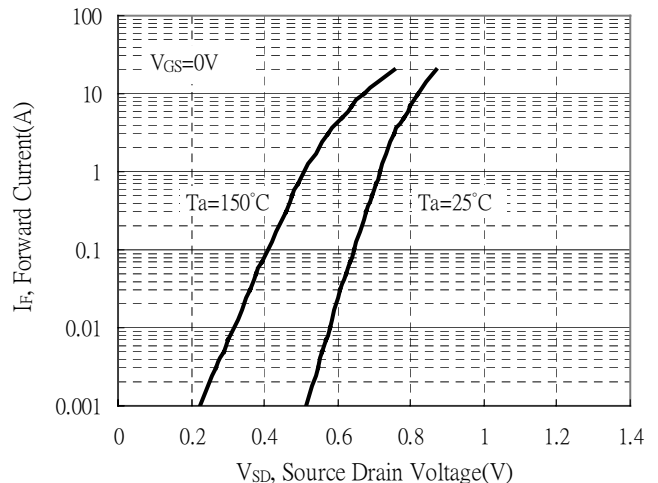
Drain Current vs Gate-Source Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

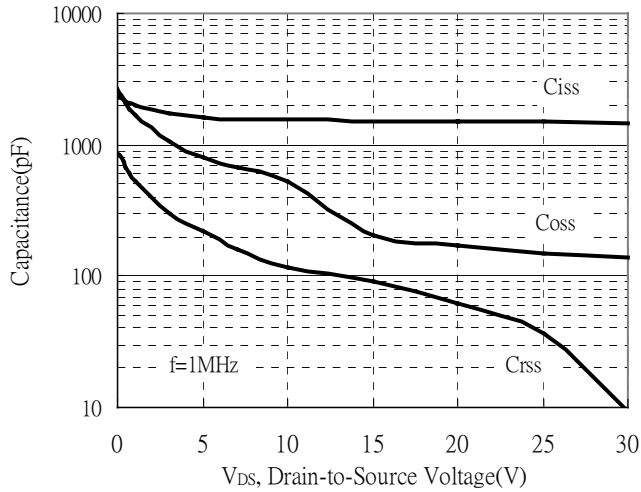


Forward Drain Current vs Source-Drain Voltage

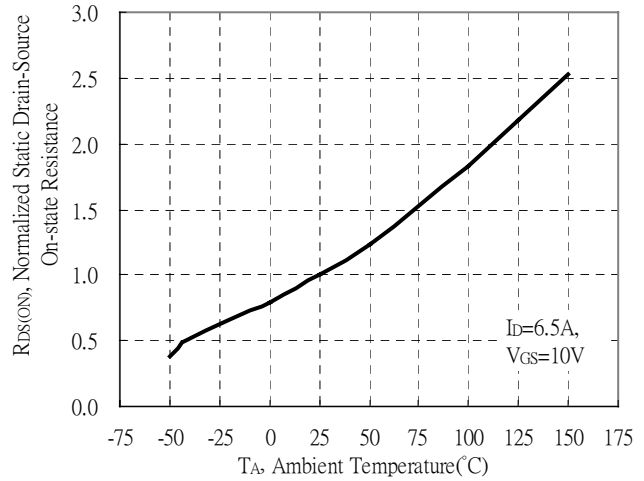


Typical Characteristics(Cont.)

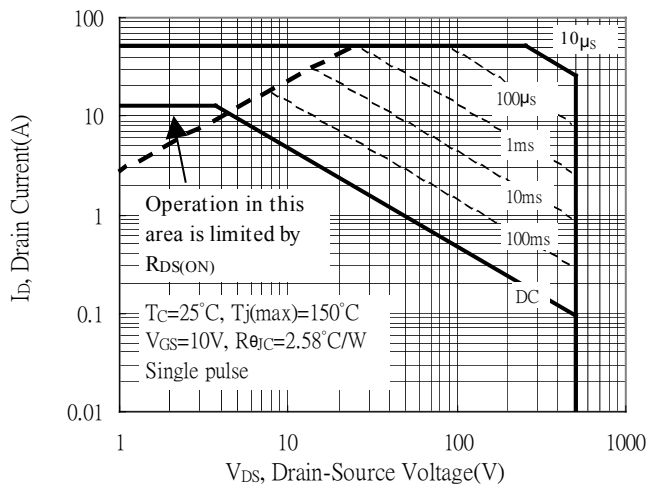
Capacitance vs Reverse Voltage



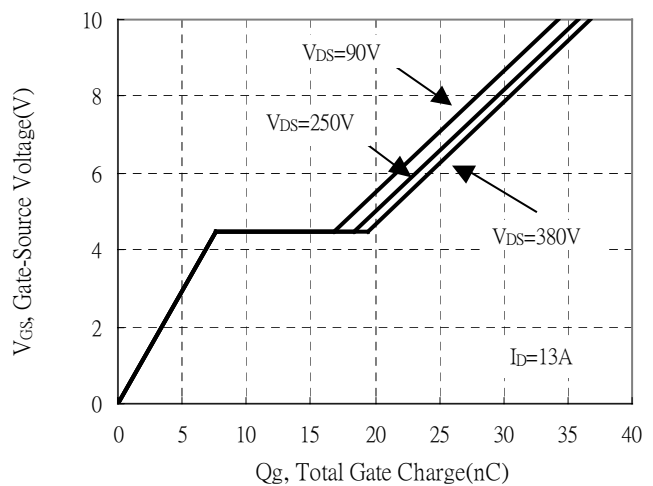
Static Drain-Source On-resistance vs Ambient Temperature



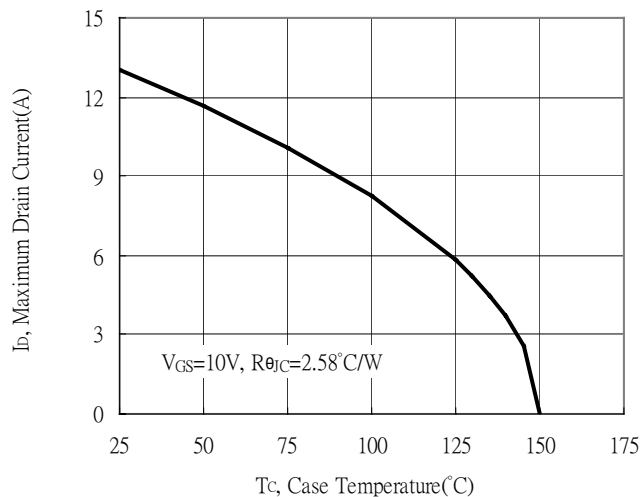
Maximum Safe Operating Area



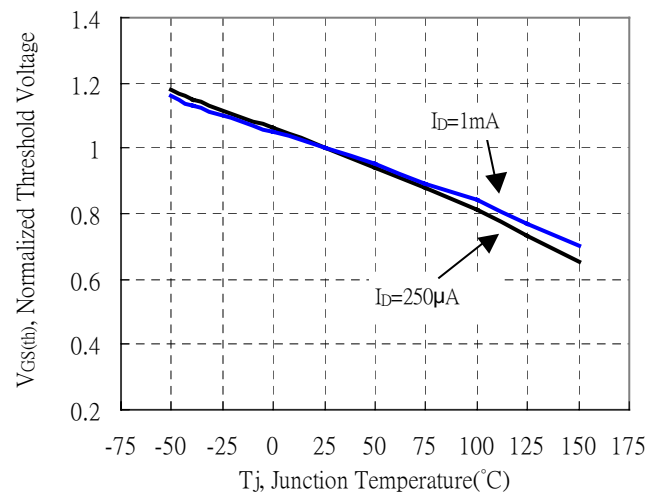
Gate Charge Characteristics



Maximum Drain Current vs Case Temperature

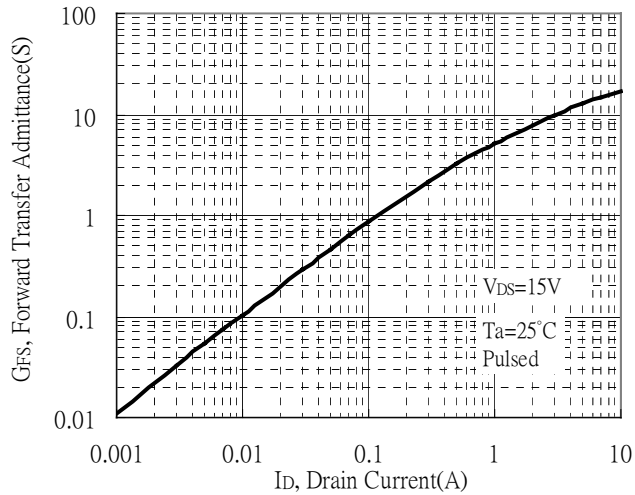


Threshold Voltage vs Junction Temperature

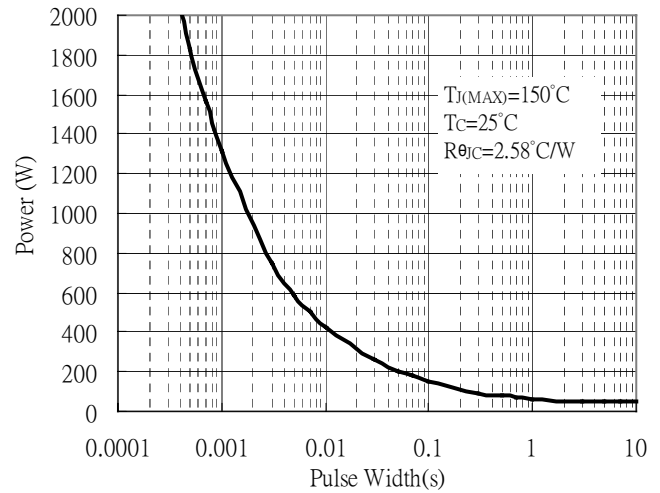


Typical Characteristics(Cont.)

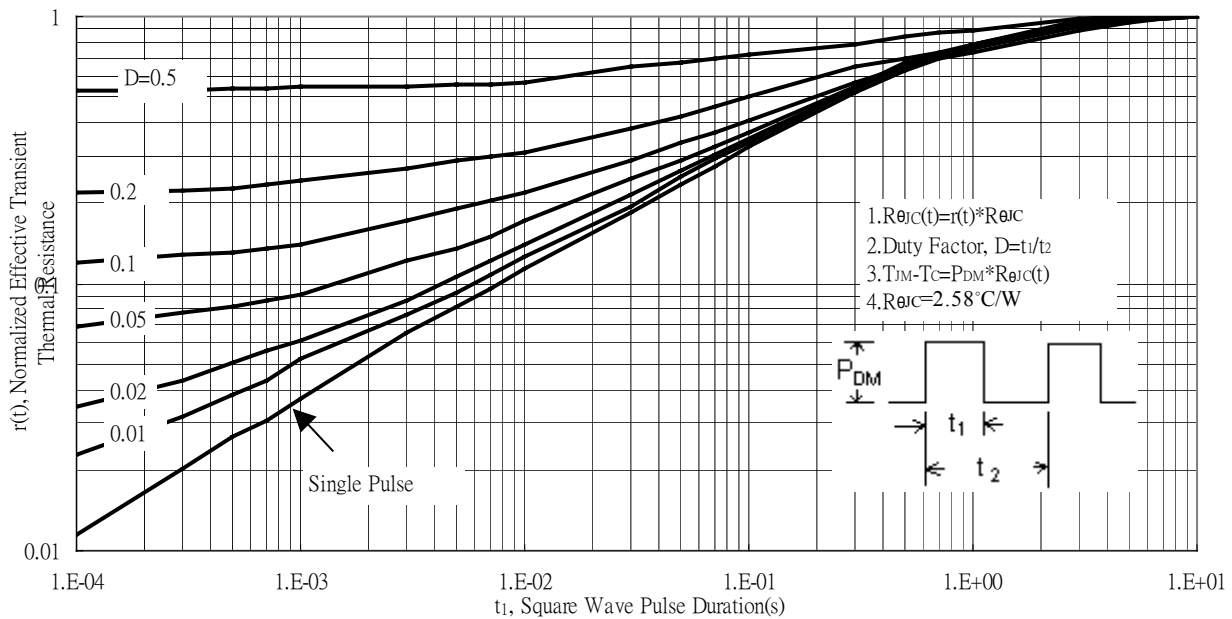
Forward Transfer Admittance vs Drain Current



Single Pulse Power Rating, Junction to Case



Transient Thermal Response Curves



Test Circuit and Waveforms

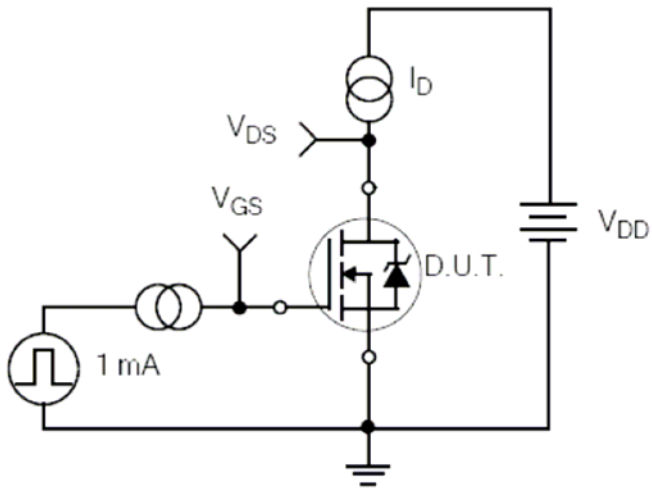


Figure 12. Gate Charge Test Circuit

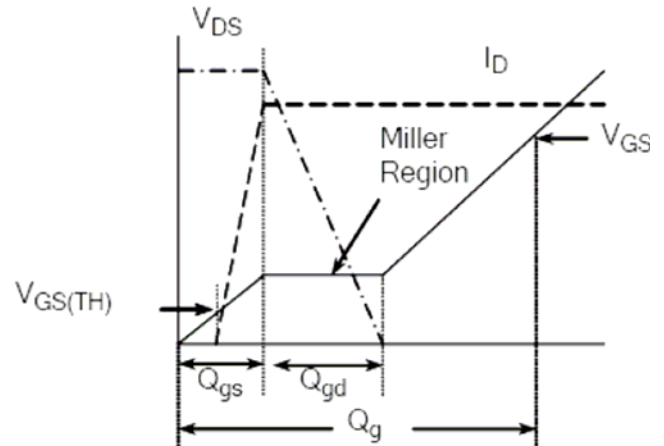


Figure 13. Gate Charge Waveform

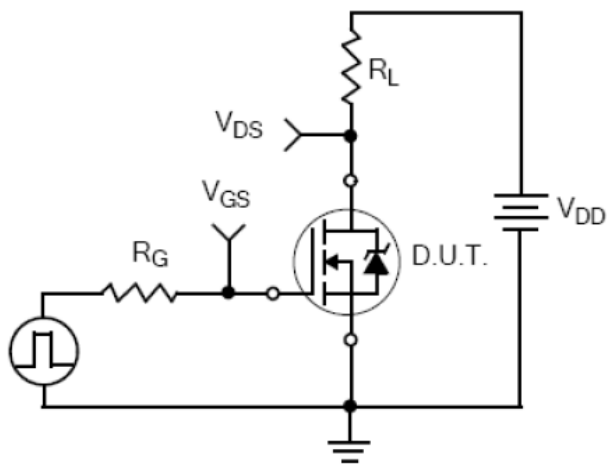


Figure 14. Resistive Switching Test Circuit

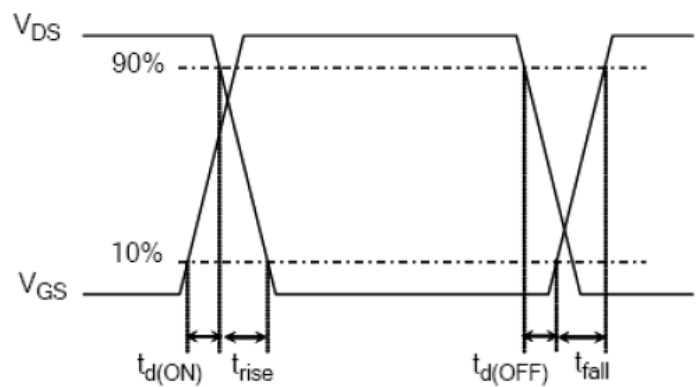


Figure 15. Resistive Switching Waveforms

Test Circuit and Waveforms(Cont.)

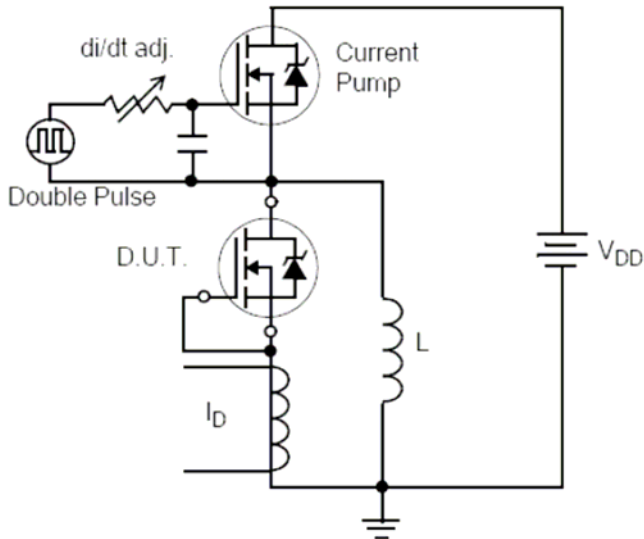


Figure 16. Diode Reverse Recovery Test Circuit

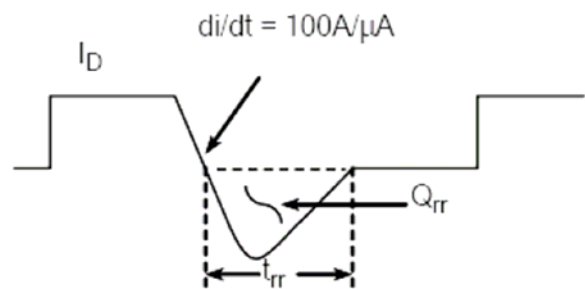


Figure 17. Diode Reverse Recovery Waveform

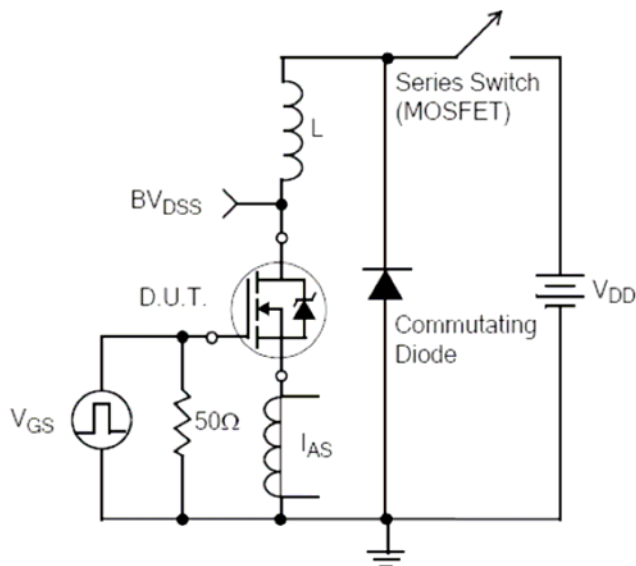


Figure 18. Unclamped Inductive Switching Test Circuit

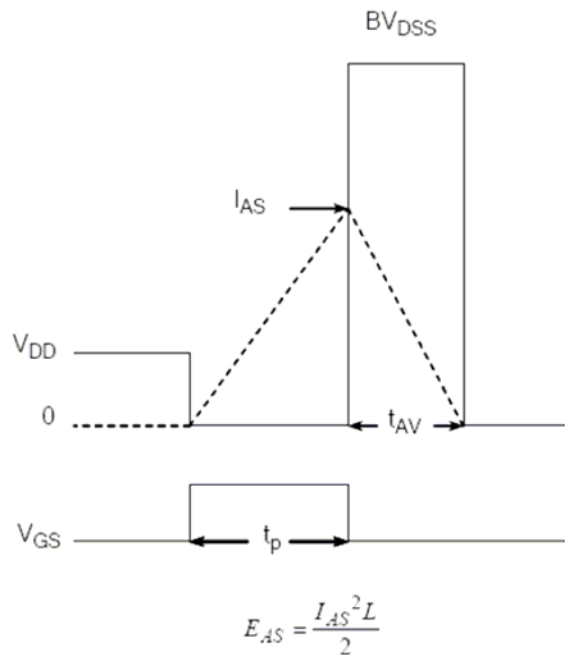
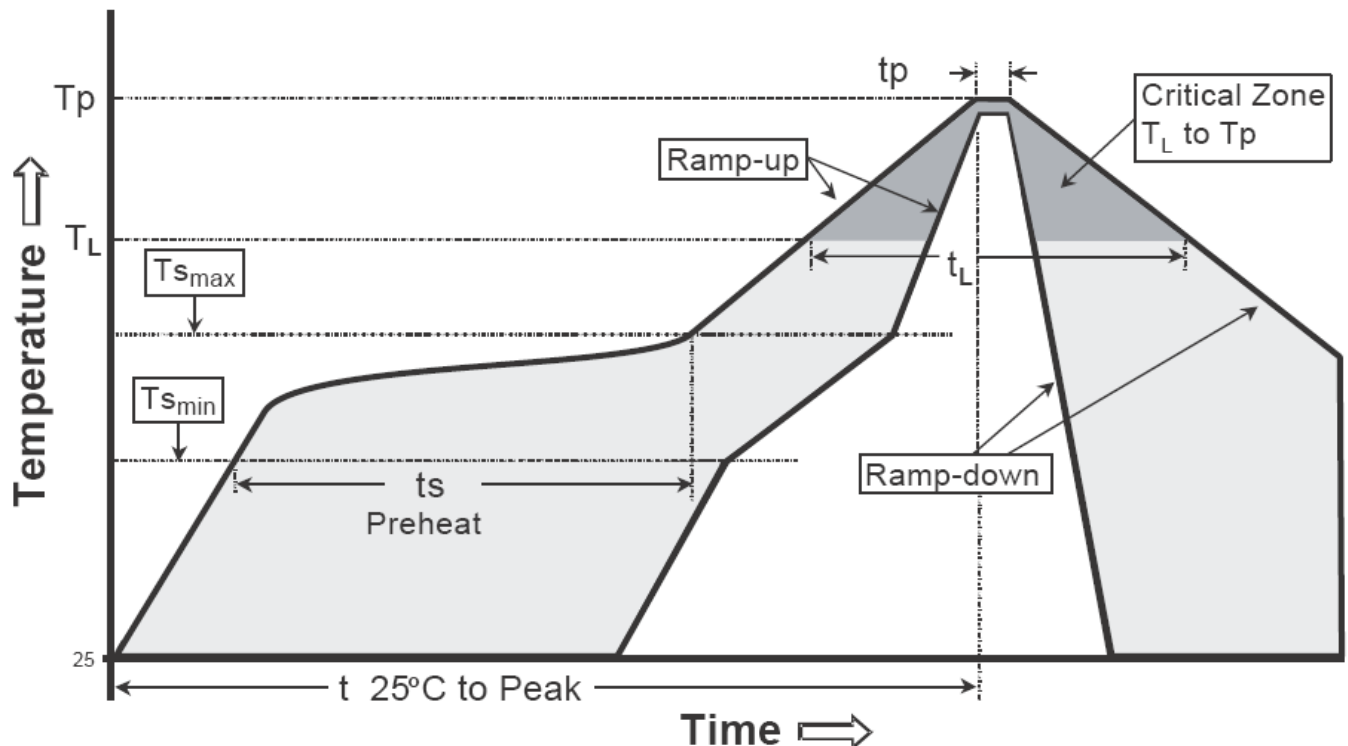


Figure 19. Unclamped Inductive Switching Waveforms

Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

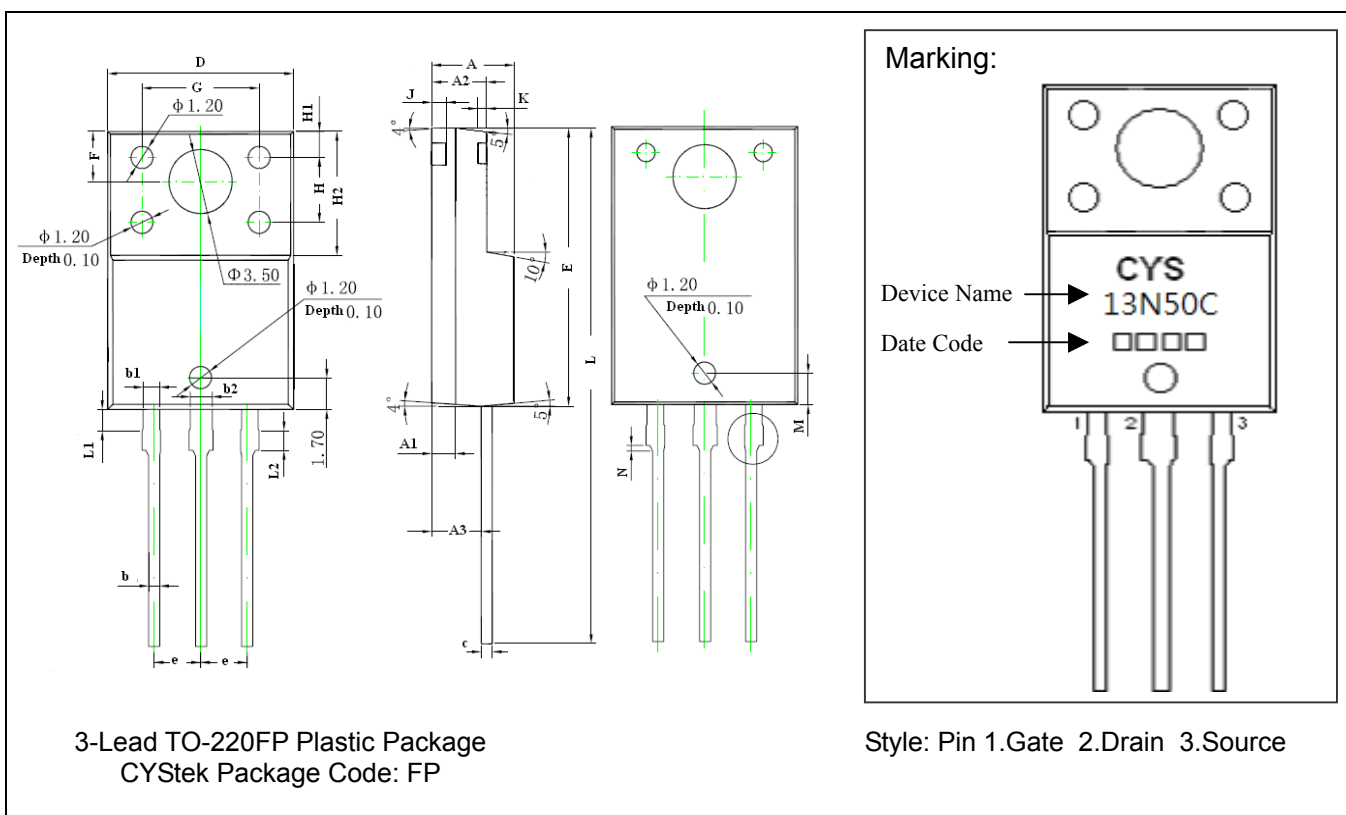
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(Tp)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

TO-220FP Dimension



*Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.171	0.183	4.35	4.65	G	0.246	0.258	6.25	6.55
A1	0.051 REF		1.300 REF		H	0.138 REF		3.50 REF	
A2	0.112	0.124	2.85	3.15	H1	0.055 REF		1.40 REF	
A3	0.102	0.110	2.60	2.80	H2	0.256	0.272	6.50	6.90
b	0.020	0.030	0.50	0.75	J	0.031 REF		0.80 REF	
b1	0.031	0.041	0.80	1.05	K	0.020		0.50 REF	
b2	0.047 REF		1.20 REF		L	1.102	1.118	28.00	28.40
c	0.020	0.030	0.500	0.750	L1	0.043	0.051	1.10	1.30
D	0.396	0.404	10.06	10.26	L2	0.036	0.043	0.92	1.08
E	0.583	0.598	14.80	15.20	M	0.067 REF		1.70 REF	
e	0.100 *		2.54*		N	0.012 REF		0.30 REF	
F	0.106 REF		2.70 REF						

Notes: 1.Controlling dimension: millimeters.

2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.

3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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